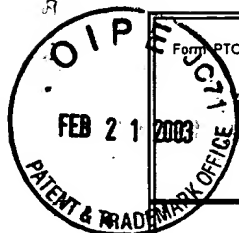


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*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
<i>RL</i> <i>RL</i> <i>RL</i> <i>RL</i> <i>RL</i> <i>RL</i>	AA	5,897,351	04/27/99	Forbes				
	AB	5,732,014	03/24/98	Forbes				
	AC	5,422,507	06/06/95	Wanlass				
	AD	5,111,069	05/05/92	Deierling et al.				
	AE	4,987,093	01/22/91	Teng et al.				
	AF							
	AG							
	AH							
	AI							
	AJ							
AK								
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
<i>RL</i>	AL	P2000-77678A	03/14/00	Japan				
	AM							
	AN							
	AO							
	AP							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
	AR							
	AS							
	AT							
EXAMINER <i>Wesley Schultz</i>				DATE CONSIDERED <i>10/16/03</i>				
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*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
Rh	AA	6,294,422 B1	09/25/2001	Sunouchi et al.			
Rh	AB	5,960,276	09/28/1999	Liaw et al.			
Rh	AC	6,107,134	08/22/2000	Lu et al.			
Rh	AD	6,124,183	09/26/2000	Karlsson et al.			
Rh	AE	6,297,082 B1	10/02/2001	Lin et al.			
Rh	AF	6,309,942 B1	10/30/2001	Tsui et al.			
Rh	AG	5,994,178	11/30/1999	Wu			
Rh	AH	6,071,792	06/06/2000	Kim et al.			
Rh	AI	6,057,210	05/02/2000	Yang et al.			
Rh	AJ	6,048,771	04/11/2000	Lin et al.			
Rh	AK	5,872,043	02/16/1999	Chen			
Rh	AL	5,923,993	07/13/1999	Sahota			
Rh	AM	5,721,172	02/24/1998	Jang et al.			
Rh	AN	5,728,621	03/17/1998	Zheng et al.			
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Rh	AS	5,702,976	12/30/1997	Schuegraf et al.			
Rh	AT	5,498,565	03/12/1996	Gocho et al.			
Rh	AU	US2002/0072199 A1	6/13/2002	Tran			
Rh	AV	US2001/0012664 A1	08/09/2001	Tran			
Rh	AW	6,048,775	4/11/2000	Yao et al.			
Rh	AX	6,057,207	5/2/2000	Lin et al.			

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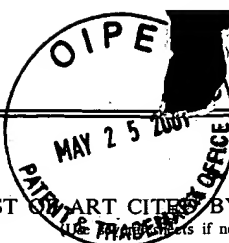
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